## DT01 Rec'd PCT/PT^ 2 4 JAN 2005 IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicants:

Shuki MIZUTANI et al.

International Application No.:

PCT/JP03/09443

International Filing Date:

July 25, 2003

For:

FACTOR TAKING PART IN TRANSCRIPTION

CONTROL

745 Fifth Avenue New York, NY 10151

## **EXPRESS MAIL**

| Mailing Label Number:  | EV375019295US  |
|--|--|
| Date of Deposit:   | January 24, 2005   |
| United States Postal S<br>Addressee" Service und<br>above and is addressed | spaper or fee is being deposited with the<br>Service "Express Mail Post Office to<br>ler 37 CFR 1.10 on the date indicated<br>to Mail Stop PCT, Commissioner for<br>Alexandria, VA 22313-1450. |
| Charles  | Jack 200   |
| (Typed or printed r  | rvice "Express Mail Post Office to<br>r 37 CFR 1.10 on the date indicated<br>o Mail Stop PCT, Commissioner for<br>lexandria, VA 22313-1450.  |
| COl, ores  | 5 Joiles.  |
| (Signature o   | f person mailing paper or fee)   |

## INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Enclosed are copies of the publications, which were cited in the International Search Report of International Application No. PCT/JP03/09443. Also enclosed is a copy of Form PTO-1449 and the International Search Report.

PATENT 10,522277 DT01 Rec'd PCT/PTC 2 4 JAN 2005

## **REMARKS**

Entry of this Information Disclosure Statement and an early examination on the merits are respectfully solicited.

Please charge any additional fees to Deposit Account No. 50-0320.

Respectfully submitted,

FROMMER LAWRENCE & HAUG LLP Attorneys for Applicants

William S. Frommer

Reg. No. 25,506

Tel. (212) 588-0800

Enclosures



Sheet 1 of 1

| Based on Form PTO-1449<br>(3/90)  | ATTY. DOCKET NO.<br>450100-04919        | SERIAL VO. 7 Z Z Z Filed Concurrently Herewith |  |  |
|---|---|--|--|--|
| LIST OF REFERENCES CITED BY APPLICANT (Use several sheets if necessary) | APPLICANT Shuki MIZUTANI et al.         |  |  |  |
|   | FILING DATE Filed Concurrently Herewith | GROUP  |  |  |

|                     |    |  | U.S            | S. PATENT DOCUMENTS   | ·                                   |                                      |  |
|---------------------|----|--|----------------|---|-------------------------------------|--------------------------------------|--|
| EXAMINER<br>INITIAL |    | DOCUMENT NUMBER  | DATE           | NAME  | CLASS                               | SUBCLASS                             | FILING DATE IF<br>APPROPRIATE          |
|                     | AA |  |                |   |                                     |                                      |  |
|                     | AB |  |                |   |                                     |                                      |  |
|                     | AC |  |                |   |                                     |                                      |  |
|                     | AD |  |                |   |                                     |                                      |  |
|                     | AE |  |                |   |                                     |                                      |  |
|                     | AF |  |                |   |                                     |                                      |  |
|                     | AG |  |                |   |                                     |                                      |  |
|                     | AH |  |                |   |                                     |                                      |  |
| 1.4-1               | ΑI |  |                |   |                                     |                                      |  |
|                     | AJ |  |                |   |                                     |                                      |  |
|                     | AK |  |                |   |                                     |                                      |  |
|                     |    | .J   | FORE           | IGN PATENT DOCUMENTS  |                                     |                                      |  |
| EXAMINER<br>INITIAL |    | DOCUMENT NUMBER  | DATE           | COUNTRY   | CLASS                               | SUBCLASS                             | TRANSLATION<br>YES NO                  |
|                     | AL | WO 01/60855  | 08/23/01       | PCT   |                                     |                                      |  |
|                     | AM | WO 01/07471  | 02/01/01       | PCT   |                                     |                                      |  |
|                     | AN | WO 01/64834  | 09/07/01       | PCT   |                                     |                                      |  |
|                     | AO | WO 99/58559  | 11/18/99       | PCT   |                                     |                                      |  |
|                     | AP | WO 00/58473  | 10/05/00       | PCT   |                                     |                                      |  |
|                     |    | OTHER P  | RIOR ART (In   | cluding Author, Title, Date, Pertinen                                       | t Pages, Etc.)                      |                                      |  |
|                     | AQ | Nakatsu Y et al., "<br>Transcription-coul<br>database Accessio | oled DNA Repa  | l Tetratricopeputide Repeat Protein lair and Transcription., J. Biol. Chem. | nvolved in Tran<br>, 2000, Vol. 275 | scription-couple<br>5, No. 45, p3493 | d DNA Repair and<br>1-34937 & SwissPro |
|                     | AR |  |                |   |                                     | A*                                   |  |
|                     | AS |  |                |   |                                     |                                      |  |
| EXAMINER            |    |  | DATE CONSIDERE | DATE CONSIDERED   |                                     |                                      |  |